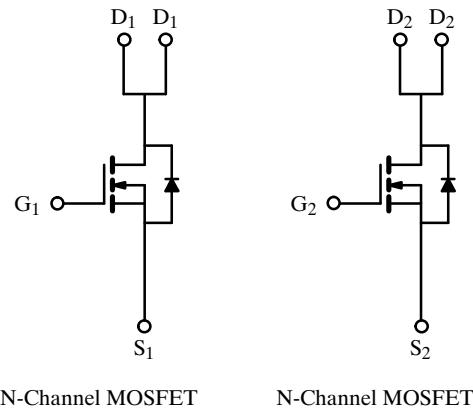
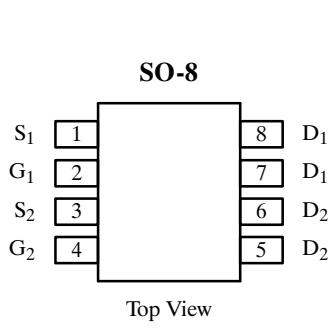


**Dual N-Channel Enhancement-Mode MOSFET****Product Summary**

<b>V<sub>DS</sub> (V)</b>	<b>r<sub>DS(on)</sub> (Ω)</b>	<b>I<sub>D</sub> (A)</b>
20	0.10 @ V <sub>GS</sub> = 10 V	± 3.5
	0.20 @ V <sub>GS</sub> = 4.5 V	± 2.0

*Recommended upgrade: Si9936DY**Lower profile/smaller size—see LITE FOOT® equivalent: Si6956DQ***Absolute Maximum Ratings (T<sub>A</sub> = 25°C Unless Otherwise Noted)**

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	20	V
Gate-Source Voltage	V <sub>GS</sub>	± 20	
Continuous Drain Current (T <sub>J</sub> = 150°C) <sup>a</sup>	I <sub>D</sub>	± 3.5	A
		± 2.8	
Pulsed Drain Current	I <sub>DM</sub>	± 14	
Continuous Source Current (Diode Conduction) <sup>a</sup>	I <sub>S</sub>	1.7	
Maximum Power Dissipation <sup>a</sup>	P <sub>D</sub>	2.0	W
		1.3	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C

**Thermal Resistance Ratings**

Parameter	Symbol	Limit	Unit
Maximum Junction-to-Ambient <sup>a</sup>	R <sub>thJA</sub>	62.5	°C/W

Notes

a. Surface Mounted on FR4 Board, t ≤ 10 sec.

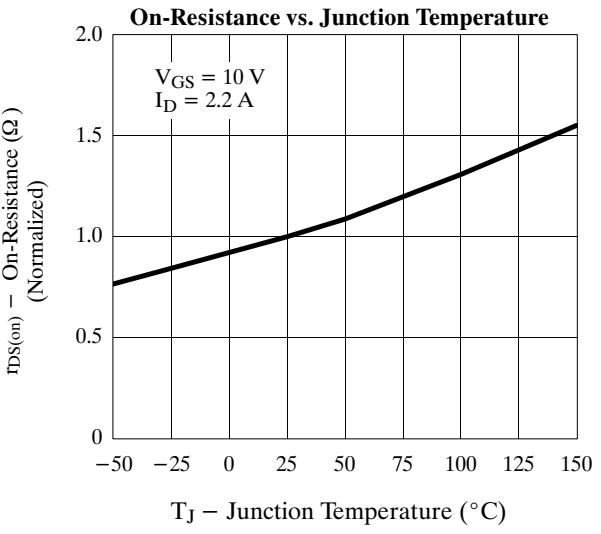
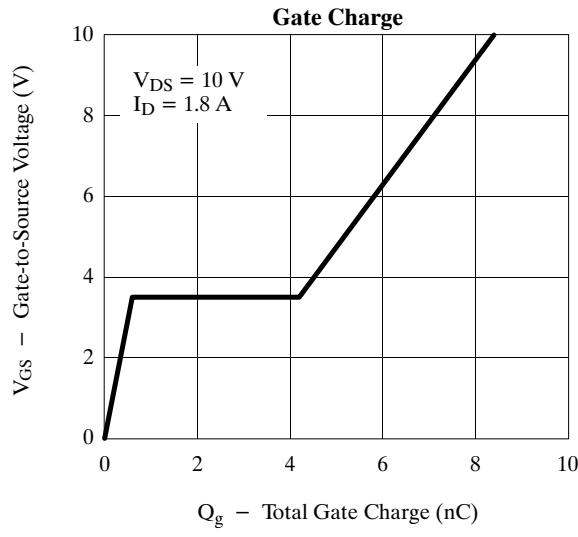
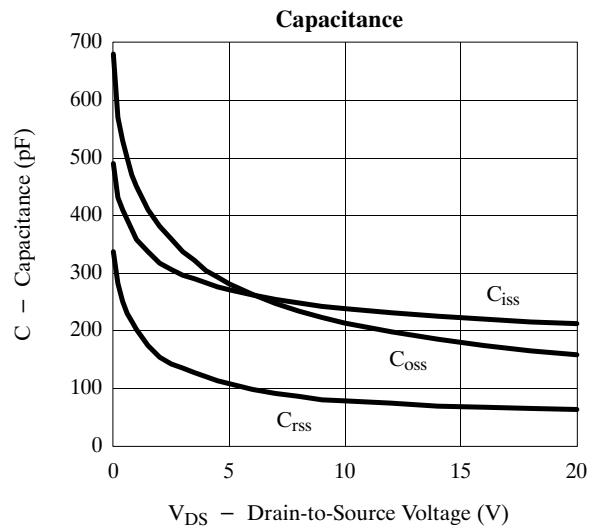
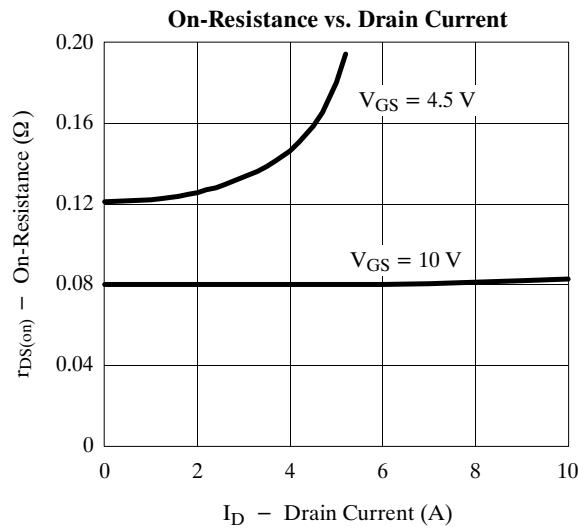
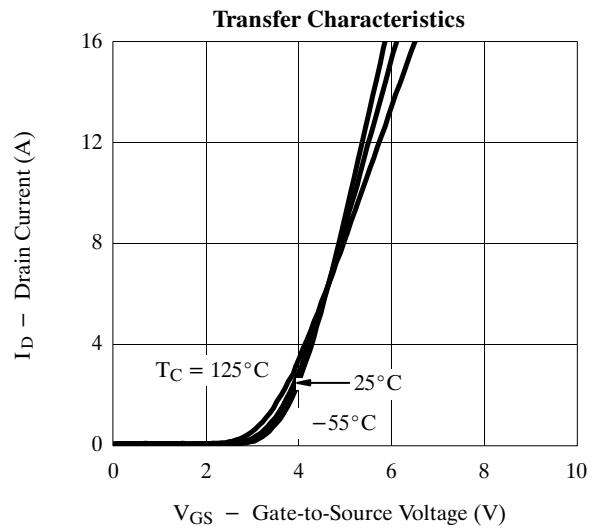
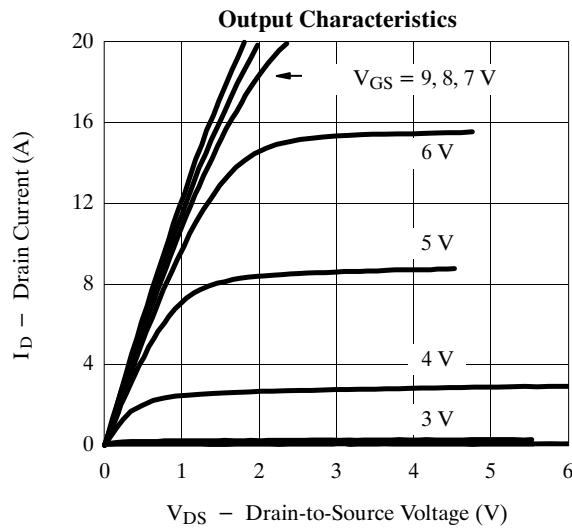
Subsequent updates to this data sheet may be obtained via facsimile by calling Siliconix FaxBack, 1-408-970-5600. Please request FaxBack document #1222.

Specifications ( $T_J = 25^\circ\text{C}$  Unless Otherwise Noted)

Parameter	Symbol	Test Condition	Min	Typ <sup>a</sup>	Max	Unit
<b>Static</b>						
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	1.0			V
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}$		2		$\mu\text{A}$
		$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55^\circ\text{C}$		25		
On-State Drain Current <sup>b</sup>	$I_{D(\text{on})}$	$V_{DS} \geq 5 \text{ V}, V_{GS} = 10 \text{ V}$	14			A
Drain-Source On-State Resistance <sup>b</sup>	$r_{DS(\text{on})}$	$V_{GS} = 10 \text{ V}, I_D = 2.2 \text{ A}$		0.08	0.10	$\Omega$
		$V_{GS} = 4.5 \text{ V}, I_D = 1 \text{ A}$		0.12	0.20	
Forward Transconductance <sup>b</sup>	$g_{fs}$	$V_{DS} = 15 \text{ V}, I_D = 3.5 \text{ A}$		5.2		S
Diode Forward Voltage <sup>b</sup>	$V_{SD}$	$I_S = 1.25 \text{ A}, V_{GS} = 0 \text{ V}$		0.9	1.4	V
<b>Dynamic<sup>a</sup></b>						
Total Gate Charge	$Q_g$	$V_{DS} = 10 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 1.8 \text{ A}$		9	30	nC
Gate-Source Charge	$Q_{gs}$			0.7		
Gate-Drain Charge	$Q_{gd}$			3.5		
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = 10 \text{ V}, R_L = 10 \Omega$ $I_D \cong 1 \text{ A}, V_{GEN} = 10 \text{ V}, R_G = 6 \Omega$		5	20	ns
Rise Time	$t_r$			12	20	
Turn-Off Delay Time	$t_{d(\text{off})}$			18	90	
Fall Time	$t_f$			10	50	
Source-Drain Reverse Recovery Time	$t_{rr}$	$I_F = 1.25 \text{ A}, di/dt = 100 \text{ A}/\mu\text{s}$		60	100	

## Notes

- a. Guaranteed by design, not subject to production testing.
- b. Pulse test; pulse width  $\leq 300 \mu\text{s}$ , duty cycle  $\leq 2\%$ .

**Typical Characteristics (25°C Unless Otherwise Noted)**

## Typical Characteristics (25°C Unless Otherwise Noted)

